

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/708,996 | Applicant(s)/Patent Under Reexamination SUN, SIMON | |
| | Examiner Rodney B. White | Art Unit 3636 | Page 1 of 2 |

| U.S. PATENT DOCUMENTS | | | | | |
|-----------------------|---|--|-----------------|-------------------|----------------|
| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
| * | A | US-5,482,349 A | 01-1996 | Richter et al. | 297/15 |
| * | B | US-5,527,087 A | 06-1996 | Takeda et al. | 297/15 |
| * | C | US-5,542,745 A | 08-1996 | Takeda et al. | 297/15X |
| * | D | US-5,941,602 A | 08-1999 | Sturt et al. | 297/15X |
| * | E | US-6,070,934 A | 06-2000 | Schaefer et al. | 297/15X |
| * | F | US-6,099,072 A | 08-2000 | Sturt et al. | 297/15 |
| * | G | US-6,123,380 A | 09-2000 | Sturt et al. | 297/15X |
| * | H | US-6,152,533 A | 11-2000 | Smuk, Wojciech | 297/15X |
| * | I | US-6,293,603 B1 | 09-2001 | Waku et al. | 297/15X |
| * | J | US-6,375,255 B1 | 04-2002 | Maruta et al. | 297/15 |
| * | K | US-2002/0067056 A1 | 06-2002 | Garrido et al. | 297/15 |
| * | L | US-6,536,843 B1 | 03-2003 | Severinski et al. | 297/15X |
| * | M | US-6,629,721 B1 | 10-2003 | Macey, Stuart P | 297/15 |

| FOREIGN PATENT DOCUMENTS | | | | | | |
|--------------------------|---|--|-----------------|---------|------|----------------|
| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

| NON-PATENT DOCUMENTS | | |
|----------------------|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/708,996 | Applicant(s)/Patent Under Reexamination SUN, SIMON | |
| | Examiner Rodney B. White | Art Unit 3636 | Page 2 of 2 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| * | A | US-6,773,067 B2 | 08-2004 | Kim, Seok Hwan | 297/15X |
| * | B | US-6,817,670 B2 | 11-2004 | Macey, Stuart P | 297/15X |
| * | C | US-6,827,394 B2 | 12-2004 | Watanabe et al. | 297/15 |
| * | D | US-6,874,840 B2 | 04-2005 | Neale, Colin G. | 297/15X |
| * | E | US-6,997,498 B2 | 02-2006 | Oyama, Rikiya | 297/15X |
| * | F | US-2006/0006704 A1 | 01-2006 | Skelly et al. | 297/188.08 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.